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-	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/658,811	MATSUMURA ET AL.	
	Examiner	Art Unit	
	Christopher RoDee	1756	

	SEARCHED			
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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(INCLUDING S	CH NOTE	RATEGY)
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Search updated		9/17/2006	CDR